

<b>Notice of References Cited</b>	Application/Control No. 09/913,670	Applicant(s)/Patent Under Reexamination DE HAAN ET AL.	
	Examiner Shawn S. An	Art Unit 2613	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,456,664 B1	09-2002	Matsumura et al.	375/240.27
*	B	US-5,748,761	05-1998	Chang et al.	382/107
*	C	US-5,933,535	08-1999	Lee et al.	382/243
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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